

<b>Notice of References Cited</b>	Application/Control No. 09/731,827	Applicant(s)/Patent Under Reexamination SHINOHARA ET AL.	
	Examiner Andrew C. Lee	Art Unit 2664	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,497,435	03-1996	Berger, Marc A.	382/249
*	B	US-5,600,373	02-1997	Chui et al.	375/240.1
*	C	US-6,128,413	10-2000	Benamara, Ali	382/251
*	D	US-5,684,693	11-1997	Li, Xuguang	702/6
*	E	US-6,609,085	08-2003	Uemura et al.	702/189
*	F	US-6,792,150	09-2004	Satoh, Masaki	382/238
*	G	US-6,327,540	12-2001	Miyano et al.	702/57
*	H	US-5,905,814	05-1999	Mochizuki et al.	382/239
*	I	US-6,594,394	07-2003	Stromberg et al.	382/232
*	J	US-6,373,986	04-2002	Fink, Ronald	382/232
*	K	US-6,404,930	06-2002	Inuzuka et al.	382/235
*	L	US-6,795,581	09-2004	Nomura, Yoshiro	382/232
*	M	US-6,301,578	10-2001	Harris, Mark	707/101

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.